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#### STP180NS04ZC

# N-channel 40 V clamped 3.6 mΩ typ., 120 A fully protected SAFeFET™ Power MOSFET in a TO-220 package

Datasheet - production data

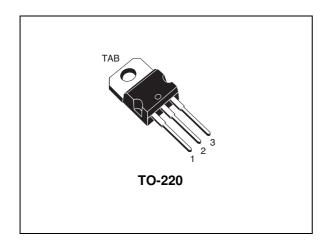
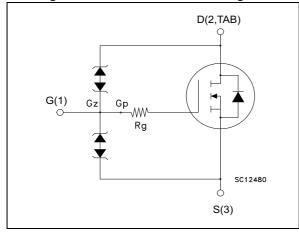


Figure 1. Internal schematic diagram



#### **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STP180NS04ZC	40 V clamped	$4.2~\text{m}\Omega$	120 A

- Low capacitance and gate charge
- 100% avalanche tested
- 175 °C maximum junction temperature

#### **Applications**

• Switching and linear applications

#### **Description**

This fully clamped Power MOSFET is manufactured using an advanced mesh overlay process which is based on an innovative strip layout. The benefits of this technology, coupled with the extra clamping capabilities render this device particularly suitable for the harshest operating conditions, such as those associated with the automotive environment. The device is also suitable for other applications that require a high degree of ruggedness.

Table 1. Device summary

Order code	Marking	Package	Packaging
STP180NS04ZC	P180NS04ZC	TO-220	Tube

Contents STP180NS04ZC

### **Contents**

1	Electrical ratings 3
2	Electrical characteristics5
	2.1 Electrical characteristics (curves)
3	Test circuits9
4	Package mechanical data 10
5	Revision history

STP180NS04ZC Electrical ratings

### 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage	41 <sup>(1)</sup>	V
V <sub>DG</sub>	Drain-gate voltage	33 <sup>(1)</sup>	V
V <sub>GS</sub>	Gate-source voltage	± 20 <sup>(1)</sup>	V
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	120	Α
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>C</sub> =100 °C	120	Α
I <sub>DG</sub>	Drain gate current (continuous)	±50	mA
I <sub>GS</sub>	Gate-source current (continuous)	±50	mA
I <sub>DM</sub> <sup>(3)</sup>	Drain current (pulsed)	480	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	330	W
	Derating factor	2.2	W/°C
ESD	Gate-source human body model (C = 100 pF, R = 1.5 k $\Omega$ )	± 8	kV
ESD	Gate-drain human body model (C = 100 pF, R = 1.5 k $\Omega$ )	± 8	kV
ESD	Drain-source human body model (C = 100 pF, R = 1.5 k $\Omega$ )	± 8	kV
T <sub>J</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 175	°C

<sup>1.</sup> Voltage is limited by Zener diodes

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	0.45	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient max	62.5	°C/W

<sup>2.</sup> Current limited by wire bonding

<sup>3.</sup> Pulse width limited by safe operating area

Electrical ratings STP180NS04ZC

Table 4. Avalanche data

Symbol	Parameter	Value	Unit
I <sub>AS</sub>	Avalanche current, repetitive or not repetitive (pulse width limited by Tjmax $\delta$ < 1%)	80	Α
E <sub>AS</sub>	Single pulse avalanche energy (starting Tj=25 °C, I <sub>D</sub> =I <sub>AS</sub> , V <sub>DD</sub> =21 V) (see Figure 17, Figure 14.)	1000	mJ

### 2 Electrical characteristics

(T<sub>CASE</sub>=25°C unless otherwise specified)

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DG</sub>	Clamped voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 -40 < Tj < 175 °C	33		41	V
V <sub>DSR(CL)</sub>	Drain-source clamping voltage (DC)	I <sub>GS(CL)</sub> = -2 mA, I <sub>D</sub> = 1 A		41		V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	$V_{DS} = 16 \text{ V}$ $V_{DS} = 16 \text{ V}, T_j = 150 \text{ °C}$ $V_{DS} = 16 \text{ V}, T_j = 175 \text{ °C}$			1 50 100	μΑ μΑ μΑ
I <sub>GSS</sub> <sup>(1)</sup>	Gate-body leakage current (V <sub>DS</sub> = 0)	$V_{GS} = \pm 10 \text{ V}$ $V_{GS} = \pm 10 \text{ V}, T_j = 175 ^{\circ}\text{C}$ $V_{GS} = \pm 16 \text{ V}, T_j = 175 ^{\circ}\text{C}$			±2 ±50 ±150	μΑ μΑ μΑ
V <sub>GSS</sub>	Gate-source breakdown voltage	$I_{GS} = \pm 100 \mu\text{A}$	18		25	V
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 1 \text{ mA}$	2	3	4	V
R <sub>DS(on)</sub>	Static drain-source on- resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 40 A		3.6	4.2	mΩ
R <sub>G</sub>	Internal gate resistor			14		Ω

<sup>1.</sup> Gate Oxide, without zener diodes, tested at wafer sorting ( $I_{GSS}$  <  $\pm$  100 nA @  $\pm$  20 V Tj=25 °C). Figure 17: Unclamped inductive load test circuit for electrical schematics

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	4500	-	pF
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> =25 V, f=1 MHz, V <sub>GS</sub> =0	-	1700	-	pF
C <sub>rss</sub>	Reverse transfer capacitance	, , , , , , , , , , , , , , , , , , ,	-	500	-	pF
t <sub>r(Voff)</sub>	Off voltage rise time	$V_{\text{CLAMP}}$ =30 V, $I_{\text{D}}$ =80 A, $V_{\text{GS}}$ =10 V, $I_{\text{G}}$ =4.7 $\Omega$ (see Figure 14)	-	250	-	ns
t <sub>f</sub>	Fall time		-	115	-	ns
t <sub>c</sub>	Cross-over time		-	290	-	ns
Qg	Total gate charge	V <sub>DD</sub> =20 V, I <sub>D</sub> = 120 A	-	110	-	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> =10 V (see Figure 15)	-	25	-	nC
Q <sub>gd</sub>	Gate-drain charge		-	45	-	nC

Electrical characteristics STP180NS04ZC

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		120	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)				480	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> =120 A, V <sub>GS</sub> =0	-		1.5	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> =120 A, di/dt = 100 A/μs,	-	56		ns
Q <sub>rr</sub>	Reverse recovery charge	V <sub>DD</sub> = 32 V, Tj=150 °C	-	70		nC
I <sub>RRM</sub>	Reverse recovery current	(see Figure 16)	-	12		Α

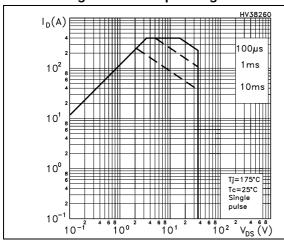
<sup>1.</sup> Pulse width limited by safe operating area

<sup>2.</sup> Pulsed: pulse duration=300  $\mu$ s, duty cycle 1.5%

#### **Electrical characteristics (curves)** 2.1

Figure 2. Safe operating area

Figure 3. Thermal impedance



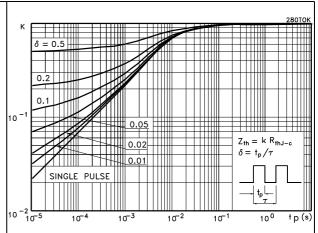
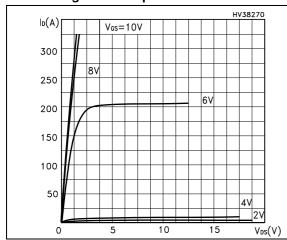


Figure 4. Output characteristics

Figure 5. Transfer characteristics



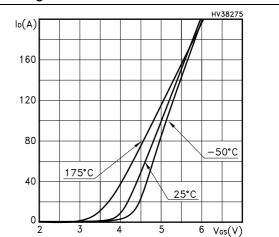
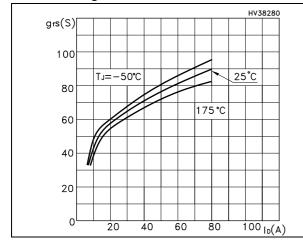
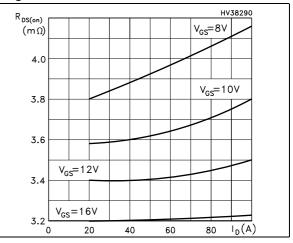


Figure 6.Transconductance

Figure 7.Static drain-source on-resistance





Electrical characteristics STP180NS04ZC

Figure 8. Gate charge vs gate-source voltage

Figure 9. Capacitance variations

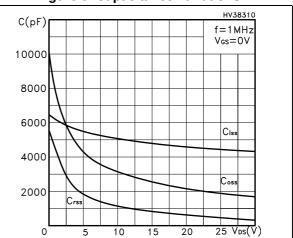
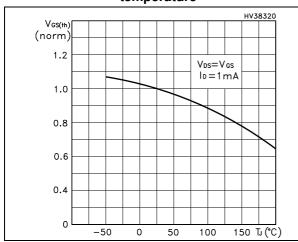


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on-resistance vs temperature



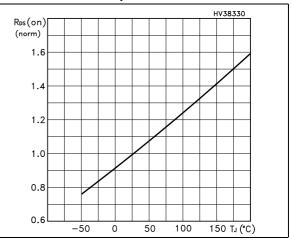
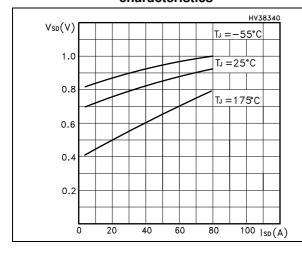
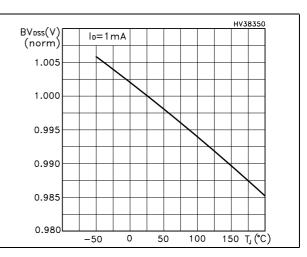


Figure 12. Source-drain diode forward characteristics

Figure 13.Normalized  $BV_{DSS}$  vs temperature





STP180NS04ZC Test circuits

#### 3 Test circuits

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

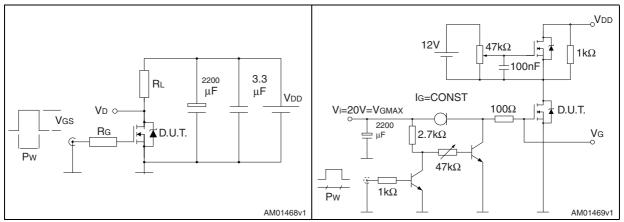


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped inductive load test circuit

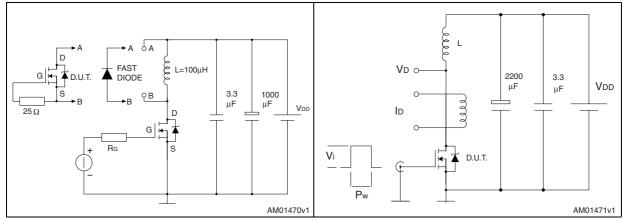
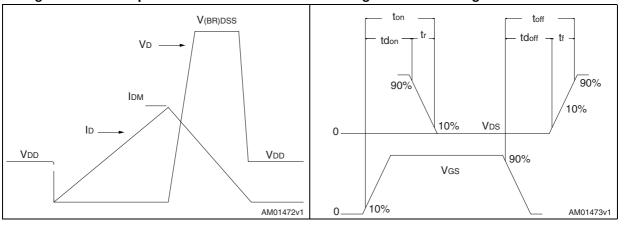


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform



# 4 Package mechanical data

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10/14 DocID14603 Rev 2

Table 8. TO-220 type A mechanical data

Dim	1000001002	mm	
Dim.	Min.	Тур.	Max.
Α	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95

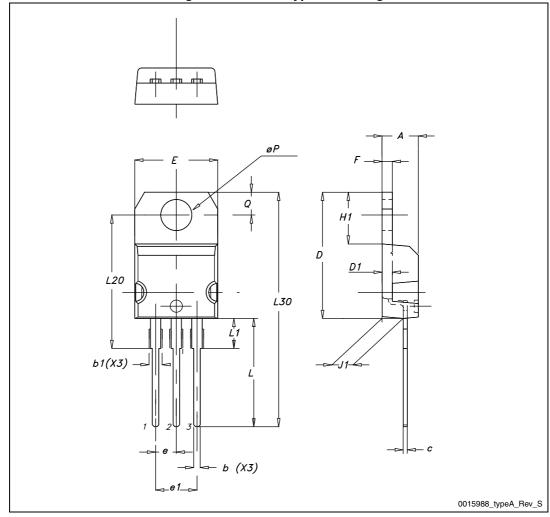


Figure 20. TO-220 type A drawing

STP180NS04ZC Revision history

# 5 Revision history

**Table 9. Document revision history** 

Date	Revision	Changes	
03-Apr-2008	1	First release.	
21-Mar-2013	2	<ul> <li>Table 1: Device summary, Table 2: Absolute maximum ratings, Table 3: Thermal data, Table 6: Dynamic have been corrected.</li> <li>Minor text changes.</li> <li>Modified: Applications section on the cover page.</li> </ul>	

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